


<b>Search Notes</b>  	<b>Application/Control No.</b>  10757626	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, JANGHWAN
	<b>Examiner</b>  HELEN SHIBRU	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
talked to Tahi about the limitation, the argument and the prior art	04/30/2008	hs
modified search	04/28/2008	hs

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner